

## EAST Search History

## EAST Search History (Prior Art)

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1927	((taking or capturing or generating or forming) near3 (image\$1 or imaging)) with ((edge or portion \$1 or part or surface or side) near3 (wafer\$1 or disc))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:05
L2	131	((((taking or capturing or generating or forming) near3 (image\$1 or imaging)) with ((edge or portion \$1 or part or surface or side) near3 (wafer\$1 or disc))) same ((database or memory or storage) with (image\$1 or imaging)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:07
L3	359	((((taking or capturing or generating or forming) near3 (image\$1 or imaging)) with ((edge or portion \$1 or part or surface or side) near3 (wafer\$1 or disc))) same ((database or memory or storage or record \$1 or recording) with (image\$1 or imaging)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:07

L4	138	(((taking or capturing or generating or forming) near3 (image\$1 or imaging)) with ((edge or portion \$1 or part or surface or side) near3 (wafer\$1 or disc))) same ((database or memory or storage or record \$1 or recording) near3 (image\$1 or imaging))	US-PGPUB; USPAT; USOCR; FFRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:08
L5	1	(((taking or capturing or generating or forming) near3 (image\$1 or imaging)) with ((edge or portion \$1 or part or surface or side) near3 (wafer\$1 or disc))) same (((database or memory or storage or record \$1 or recording) near3 (image\$1 or imaging)) same ((subsequent or next or following or further) near4 (analysis or analyzing or analyz \$2)))	US-PGPUB; USPAT; USOCR; FFRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:10

L6	1	(((taking or capturing or generating or forming) near3 (image\$1 or imaging)) with ((edge or portion \$1 or part or surface or side) near3 (wafer\$1 or disc))) and (((database or memory or storage or record \$1 or recording) near3 (image\$1 or imaging)) same ((subsequent or next or following or further) near4 (analysis or analyzing or analyz \$2)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:10
L7	1	(((taking or capturing or generating or forming) near3 (image\$1 or imaging)) with ((edge or portion \$1 or part or surface or side) near3 (wafer\$1 or disc))) and (((database or memory or storage or record \$1 or recording) near3 (image\$1 or imaging)) with ((subsequent or next or following or further) near4 (analysis or analyzing or analyz \$2)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:11

L8	13	((((taking or capturing or generating or forming) near3 (image\$1 or imaging)) with ((edge or portion \$1 or part or surface or side) near3 (wafer\$1 or disc))) and (((database or memory or storage or record \$1 or recording) near3 (image\$1 or imaging)) and ((subsequent or next or following or further) near4 (analysis or analyzing or analyz \$2))))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:11
L9	17366	(capturing adj3 device) and (received adj3 image) adn (subsequent adj3 analysis) and (defect adj3 inspection)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:19
L10	17134	(capturing adj3 device) and (received adj3 image) adn (subsequent adj3 analysis) and (defect adj3 inspection) and (fabrication adj3 system) and (second adj3 image)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:21

L11	1	(capturing adj3 device) and (received adj3 image) and (subsequent adj3 analysis) and (defect adj3 inspection) and (fabrication adj3 system) and (second adj3 image)	US-PGPUB; USPAT; USOCR; FFRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:21
L12	0	(capturing adj3 device) and (recorded adj3 images) and (desired adj3 angle) and (defect adj3 information) and (scanning adj3 step)	US-PGPUB; USPAT; USOCR; FFRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:24
L13	0	(capturing adj3 device) and (recorded adj3 images) and (desired adj3 angle) and (defect adj3 information)	US-PGPUB; USPAT; USOCR; FFRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:25
L14	0	(scanned adj3 wafer) and (recorded adj3 images) and (desired adj3 angle) and (defect adj3 information)	US-PGPUB; USPAT; USOCR; FFRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:25
L16	1	(capturing adj3 device) and (received adj3 image) and (subsequent adj3 analysis) and (defect adj3 inspection) and (fabrication adj3 system) and (second adj3 image)	US-PGPUB; USPAT; USOCR; FFRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/12 16:26

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